

SANYO Semiconductors

DATA SHEET

An ON Semiconductor Company

5LN01C -

N-Channel Silicon MOSFET **General-Purpose Switching Device Applications**

Features

- · Low ON-resistance
- · Ultrahigh-speed switching
- 2.5V drive

Specifications

Absolute Maximum Ratings at Ta=25°C

| Parameter | Symbol | Conditions | Ratings | Unit |
|-----------------------------|--------|------------------------|-------------|------|
| Drain-to-Source Voltage | VDSS | | 50 | V |
| Gate-to-Source Voltage | VGSS | | ±10 | V |
| Drain Current (DC) | ID | | 0.1 | А |
| Drain Current (Pulse) | IDP | PW≤10μs, duty cycle≤1% | 0.4 | А |
| Allowable Power Dissipation | PD | | 0.25 | W |
| Channel Temperature | Tch | | 150 | °C |
| Storage Temperature | Tstg | | -55 to +150 | °C |

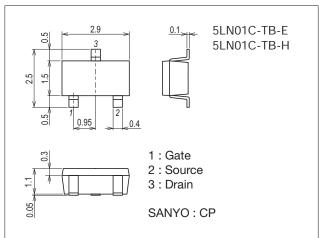
This product is designed to "ESD immunity < 200V*", so please take care when handling.

* Machine Model

Package Dimensions

unit : mm (typ)

7013A-013



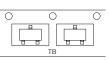
Product & Package Information

- Package
- JEITA, JEDEC
- : SC-59, TO-236, SOT-23, TO-236AB • Minimum Packing Quantity : 3,000 pcs./reel

: CP

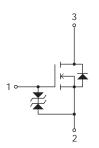
Packing Type: TB

Marking





Electrical Connection

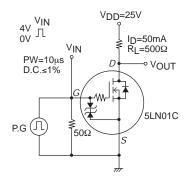


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| Electrical Cha | racteristics at Ta=25°C |
|-----------------------|-------------------------|
|-----------------------|-------------------------|

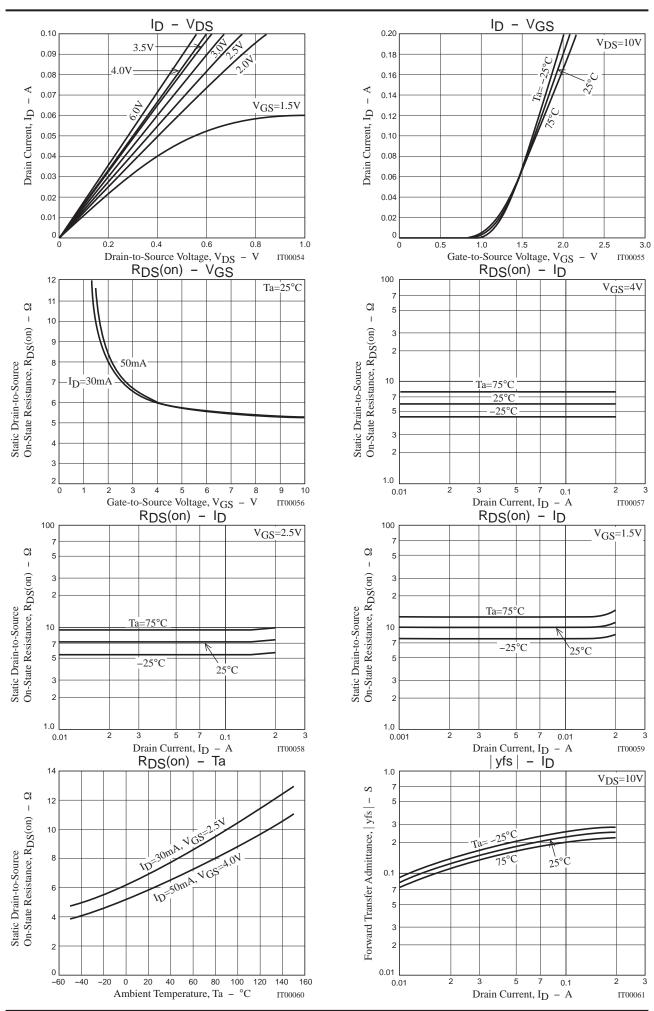
| Deservation | Cumbral | | | Ratings | | |
|--|-----------------------|---|------|---------|-----|------|
| Parameter | Symbol | Conditions | min | typ | max | Unit |
| Drain-to-Source Breakdown Voltage | V(BR)DSS | ID=1mA, VGS=0V | 50 | | | V |
| Zero-Gate Voltage Drain Current | IDSS | V _{DS} =50V, V _{GS} =0V | | | 1 | μΑ |
| Gate-to-Source Leakage Current | IGSS | V _{GS} =±8V, V _{DS} =0V | | | ±10 | μΑ |
| Cutoff Voltage | V _{GS} (off) | V _{DS} =10V, I _D =100µA 0.4 | | | 1.3 | V |
| Forward Transfer Admittance | yfs | VDS=10V, ID=50mA | 0.13 | 0.18 | | S |
| Static Drain-to-Source On-State Resistance | R _{DS} (on)1 | ID=50mA, VGS=4V | | 6 | 7.8 | Ω |
| | R _{DS} (on)2 | ID=30mA, VGS=2.5V | | 7.1 | 9.9 | Ω |
| | R _{DS} (on)3 | ID=10mA, VGS=1.5V | | 10 | 20 | Ω |
| Input Capacitance | Ciss | | | 6.6 | | рF |
| Output Capacitance | Coss | VDS=10V, f=1MHz | | 4.7 | | рF |
| Reverse Transfer Capacitance | Crss | - | | 1.7 | | рF |
| Turn-ON Delay Time | t _d (on) | | | 18 | | ns |
| Rise Time | tr | | | 42 | | ns |
| Turn-OFF Delay Time | t _d (off) | See specified Test Circuit. | | 190 | | ns |
| Fall Time | tf | 1 | | 105 | | ns |
| Total Gate Charge | Qg | | | 1.57 | | nC |
| Gate-to-Source Charge | Qgs | V _{DS} =10V, V _{GS} =10V, I _D =100mA | | 0.20 | | nC |
| Gate-to-Drain "Miller" Charge | Qgd | 1 | | 0.32 | | nC |
| Diode Forward Voltage | V _{SD} | IS=100mA, VGS=0V | | 0.85 | 1.2 | V |

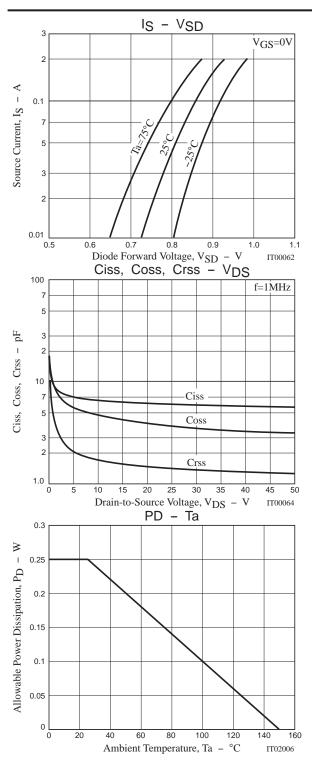
Switching Time Test Circuit

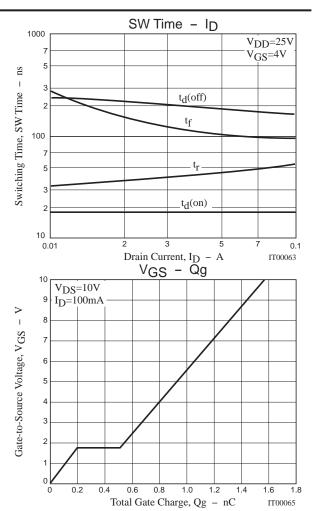


Ordering Information

| 0 | | | | |
|----------------|----|----------------|--------------------------|--|
| Device Package | | Shipping | memo | |
| 5LN01C-TB-E | CP | 3,000pcs./reel | Pb Free | |
| 5LN01C-TB-H | СР | 3,000pcs./reel | Pb Free and Halogen Free | |

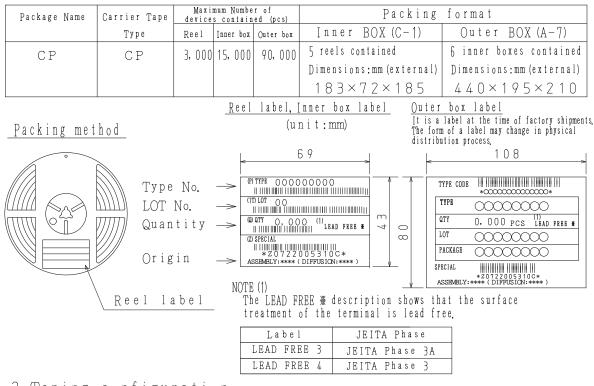




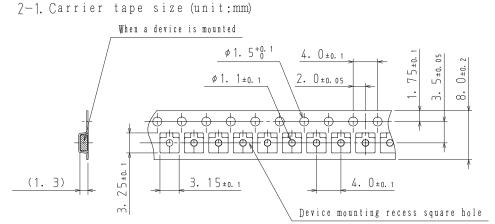


Embossed Taping Specification 5LN01C-TB-E, 5LN01C-TB-H

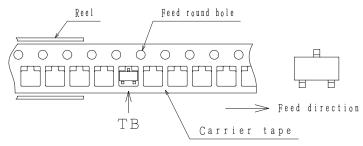
1. Packing Format



2. Taping configuration

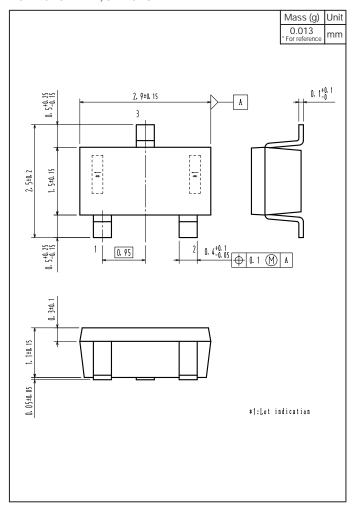


2-2. Device placement direction

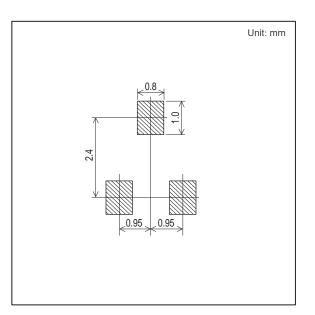


Those with one electrode terminal on the feed hole side ·····TB

Outline Drawing 5LN01C-TB-E, 5LN01C-TB-H



Land Pattern Example



Note on usage : Since the 5LN01C is a MOSFET product, please avoid using this device in the vicinity of highly charged objects.

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